



Advanced Photon Source

» an Office of Science User Facility



Calendar of Events beta

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To report an event that is not listed, [contact webmaster](#).

TODAY

Mar 25
Friday

Studies of Iron-Carbon-Oxygen Phases at Extreme Conditions: Single Crystal and Multigrain Analysis, Spin Transition, Synthesis of High Pressure Phases

Speaker: Barbara Lavina, HiPSEC and Department of Physics and Astronomy University of Nevada, Las Vegas

XSD Presentation

401/A1100 @ 11:00 AM

[View Description](#)

User Science Seminar

APS Seminar

401/A1100 @ 12:00 PM

On the Performance of Multilayers Used as Monochromators for Coherent X-ray Imaging with Hard Synchrotron Radiation

Speaker: Alexander Rack, European Synchrotron Radiation Facility

XSD Presentation

401/A1100 @ 1:30 PM

[View Description](#)

We present a systematic study in which multilayers of different composition (W/Si, Mo/Si, Pd/B4C, Ru/B4C, W/B4C), periodicity (from 2.5 to 5.5 nm), and numbers of layers have been characterized. Particularly, we investigated the intrinsic quality (roughness and reflectivity) as well as the performance (flatness and coherence of the outgoing beam) as a monochromator for synchrotron radiation hard X-ray micro-imaging. The results indicate that the material composition is the dominating factor for the performance. Current experiments at 32-ID of APS are foreseen combined with a round-robin of different multilayer laboratories to verify and understand the influence of the material composition. This is of high importance for synchrotron-based hard X-ray imaging which has become a widely applied tool for probing the microstructure of bulk samples. The high spatial resolution and different contrast modalities available here strongly depend on using coherent beams from highly brilliant sources. In order to satisfy the demand for a high flux of quasi-monochromatic photons, multilayer-coated mirrors are commonly used as monochromators. This comes at the cost of reduced energy resolution and stronger non-uniformities in the incoming beam profile. By helping scientists and engineers specify the design parameters of multilayer monochromators, our results can contribute to a better exploitation of the advantages of multilayer monochromators over crystal-based devices for X-ray imaging.

[\[Hide \]](#)

UPCOMING

Mar 28
Monday

In Situ Experiments in X-ray Imaging -- Application to Materials Science

Speaker: Eric Maire, Mateis Lab, Institut National des Sciences Appliquées (INSA)

XSD Presentation

431/C010 @ 3:00 PM

[View Description](#)

Mar 30
Wednesday

APS/Users Operations Monthly Meeting

APS Meeting

402/AUD @ 2:30 PM

Apr 1
Friday

User Science Seminar

APS Seminar

401/A1100 @ 12:00 PM

Apr 8
Friday

User Science Seminar

APS Seminar

March 2011

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